

Notice of References Cited	Application/Control No. 10/720,342	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0207339 A1	10-2004	Lin et al.	315/291
*	B	US-6,680,588 B2	01-2004	Park et al.	315/312
	C	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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